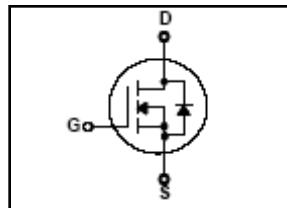
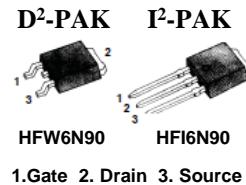


## HFW6N90 / HFI6N90 900V N-Channel MOSFET

### FEATURES

- Originative New Design
- Superior Avalanche Rugged Technology
- Robust Gate Oxide Technology
- Very Low Intrinsic Capacitances
- Excellent Switching Characteristics
- Unrivalled Gate Charge : 35 nC (Typ.)
- Extended Safe Operating Area
- Lower  $R_{DS(ON)}$  : 1.95 Ω (Typ.) @ $V_{GS}=10V$
- 100% Avalanche Tested

|  |
|--|
| $BV_{DSS} = 900 V$                     |
| $R_{DS(on)} \text{ typ} = 1.95 \Omega$ |
| $I_D = 6.0 A$                          |



### Absolute Maximum Ratings $T_C=25^\circ C$ unless otherwise specified

| Symbol         | Parameter   | Value       | Units |
|----------------|---|-------------|-------|
| $V_{DSS}$      | Drain-Source Voltage  | 900         | V     |
| $I_D$          | Drain Current – Continuous ( $T_C = 25^\circ C$ )                             | 6.0         | A     |
|                | Drain Current – Continuous ( $T_C = 100^\circ C$ )                            | 3.8         | A     |
| $I_{DM}$       | Drain Current – Pulsed (Note 1)   | 24          | A     |
| $V_{GS}$       | Gate-Source Voltage   | $\pm 30$    | V     |
| $E_{AS}$       | Single Pulsed Avalanche Energy (Note 2)                                       | 650         | mJ    |
| $I_{AR}$       | Avalanche Current (Note 1)  | 6.0         | A     |
| $E_{AR}$       | Repetitive Avalanche Energy (Note 1)  | 16.7        | mJ    |
| $dv/dt$        | Peak Diode Recovery $dv/dt$ (Note 3)  | 4.5         | V/ns  |
| $P_D$          | Power Dissipation ( $T_A = 25^\circ C$ ) *                                    | 3.13        | W     |
|                | Power Dissipation ( $T_C = 25^\circ C$ ) – Derate above $25^\circ C$          | 167         | W     |
|                |   | 1.33        | W/°C  |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range                                       | -55 to +150 | °C    |
| $T_L$          | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | 300         | °C    |

### Thermal Resistance Characteristics

| Symbol          | Parameter            | Typ. | Max. | Units |
|-----------------|----------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case     | --   | 0.75 | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient* | --   | 40   |       |
| $R_{\theta JA}$ | Junction-to-Ambient  | --   | 62.5 |       |

\* When mounted on the minimum pad size recommended (PCB Mount)

**Electrical Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise specified

| Symbol                         | Parameter                                 | Test Conditions  | Min | Typ  | Max  | Units                     |
|--------------------------------|---|--|-----|------|------|---------------------------|
| <b>On Characteristics</b>      |   |  |     |      |      |                           |
| $V_{GS}$                       | Gate Threshold Voltage                    | $V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$                | 2.5 | --   | 4.5  | V                         |
| $R_{DS(\text{ON})}$            | Static Drain-Source On-Resistance         | $V_{GS} = 10 \text{ V}$ , $I_D = 3.0 \text{ A}$            | --  | 1.95 | 2.4  | $\Omega$                  |
| <b>Off Characteristics</b>     |   |  |     |      |      |                           |
| $BV_{DSS}$                     | Drain-Source Breakdown Voltage            | $V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$           | 900 | --   | --   | V                         |
| $\Delta BV_{DSS} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$ | --  | 1.03 | --   | $\text{V}/^\circ\text{C}$ |
| $I_{DSS}$                      | Zero Gate Voltage Drain Current           | $V_{DS} = 900 \text{ V}$ , $V_{GS} = 0 \text{ V}$          | --  | --   | 1    | $\mu\text{A}$             |
|                                |   | $V_{DS} = 720 \text{ V}$ , $T_C = 125^\circ\text{C}$       | --  | --   | 10   | $\mu\text{A}$             |
| $I_{GSSF}$                     | Gate-Body Leakage Current, Forward        | $V_{GS} = 30 \text{ V}$ , $V_{DS} = 0 \text{ V}$           | --  | --   | 100  | nA                        |
| $I_{GSSR}$                     | Gate-Body Leakage Current, Reverse        | $V_{GS} = -30 \text{ V}$ , $V_{DS} = 0 \text{ V}$          | --  | --   | -100 | nA                        |

**Dynamic Characteristics**

|           |                              |   |    |      |      |    |
|-----------|------------------------------|---|----|------|------|----|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = 25 \text{ V}$ , $V_{GS} = 0 \text{ V}$ ,<br>$f = 1.0 \text{ MHz}$ | -- | 1550 | 2010 | pF |
| $C_{oss}$ | Output Capacitance           |   | -- | 110  | 145  | pF |
| $C_{rss}$ | Reverse Transfer Capacitance |   | -- | 15   | 20   | pF |

**Switching Characteristics**

|              |                     |   |    |     |     |    |
|--------------|---------------------|---|----|-----|-----|----|
| $t_{d(on)}$  | Turn-On Time        | $V_{DS} = 450 \text{ V}$ , $I_D = 6.0 \text{ A}$ ,<br>$R_G = 25 \Omega$<br><br>(Note 4,5)       | -- | 40  | 80  | ns |
| $t_r$        | Turn-On Rise Time   |   | -- | 120 | 240 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time |   | -- | 60  | 120 | ns |
| $t_f$        | Turn-Off Fall Time  |   | -- | 70  | 140 | ns |
| $Q_g$        | Total Gate Charge   | $V_{DS} = 720 \text{ V}$ , $I_D = 6.0 \text{ A}$ ,<br>$V_{GS} = 10 \text{ V}$<br><br>(Note 4,5) | -- | 35  | 45  | nC |
| $Q_{gs}$     | Gate-Source Charge  |   | -- | 10  | --  | nC |
| $Q_{gd}$     | Gate-Drain Charge   |   | -- | 13  | --  | nC |

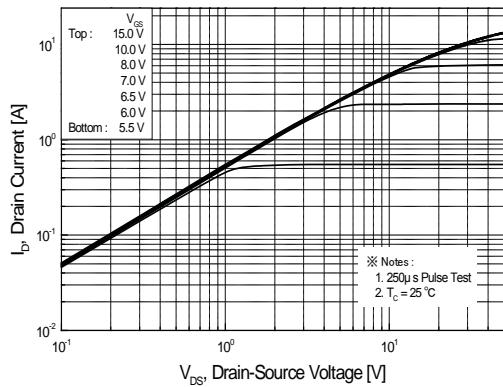
**Source-Drain Diode Maximum Ratings and Characteristics**

|          |   |  |    |     |     |               |
|----------|---|--|----|-----|-----|---------------|
| $I_S$    | Continuous Source-Drain Diode Forward Current | --   | -- | 6.0 | A   |               |
| $I_{SM}$ | Pulsed Source-Drain Diode Forward Current     | --   | -- | 24  |     |               |
| $V_{SD}$ | Source-Drain Diode Forward Voltage            | $I_S = 6.0 \text{ A}$ , $V_{GS} = 0 \text{ V}$   |    | --  | 1.4 | V             |
| $trr$    | Reverse Recovery Time                         | $I_S = 6.0 \text{ A}$ , $V_{GS} = 0 \text{ V}$<br>$di_F/dt = 100 \text{ A}/\mu\text{s}$ (Note 4) | -- | 780 | --  | ns            |
| $Qrr$    | Reverse Recovery Charge                       |  | -- | 9.0 | --  | $\mu\text{C}$ |

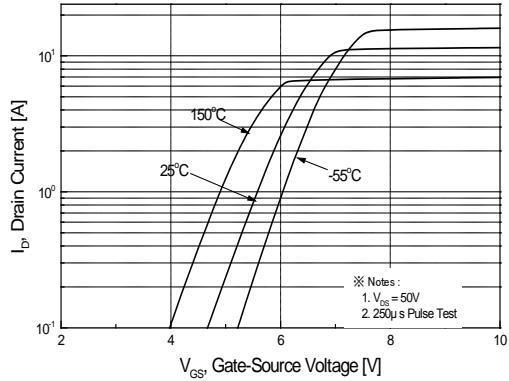
**Notes :**

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $L=34\text{mH}$ ,  $I_{AS}=6.0\text{A}$ ,  $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
- $I_{SD}\leq 6.0\text{A}$ ,  $di/dt\leq 200\text{A}/\mu\text{s}$ ,  $V_{DD}\leq BV_{DSS}$ , Starting  $T_J=25^\circ\text{C}$
- Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- Essentially Independent of Operating Temperature

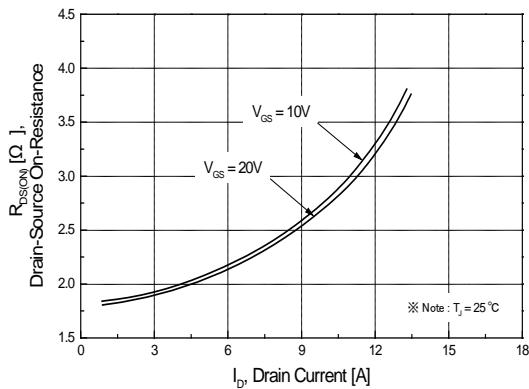
## Typical Characteristics



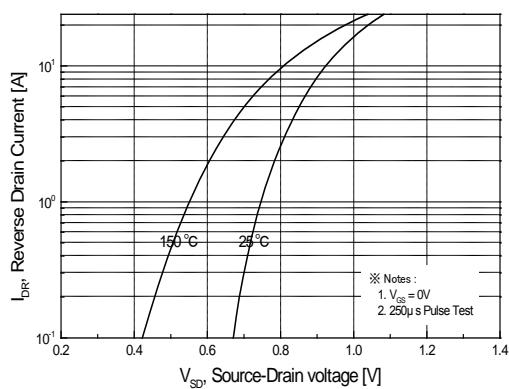
**Figure 1. On Region Characteristics**



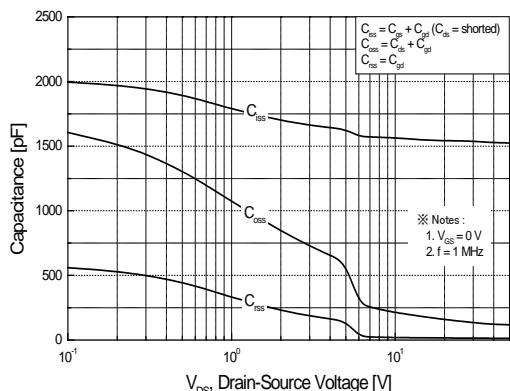
**Figure 2. Transfer Characteristics**



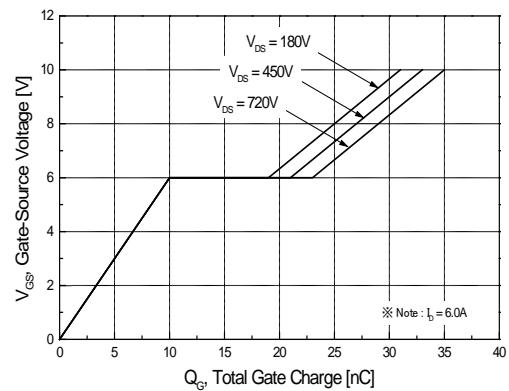
**Figure 3. On Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

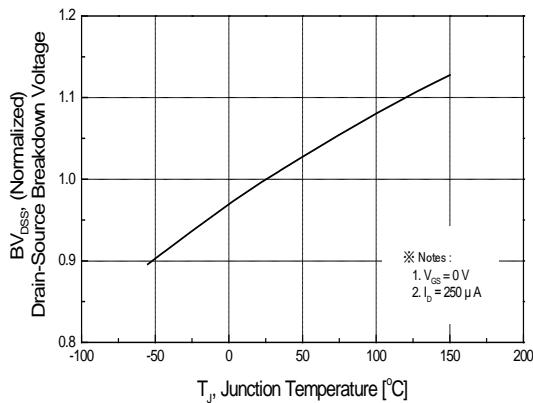


**Figure 5. Capacitance Characteristics**

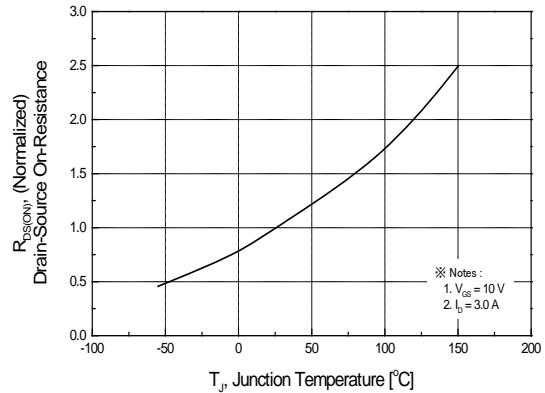


**Figure 6. Gate Charge Characteristics**

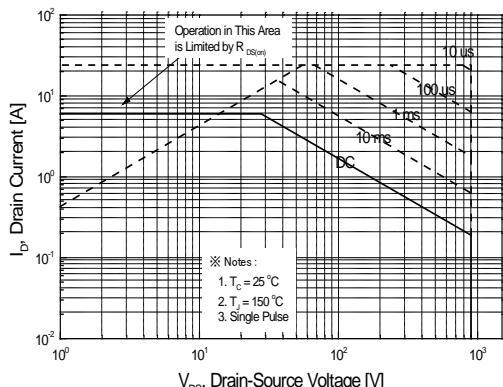
## Typical Characteristics (continued)



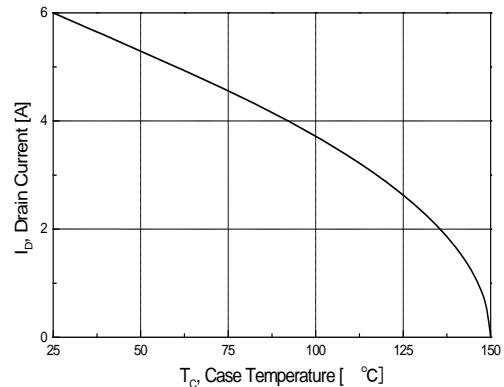
**Figure 7. Breakdown Voltage Variation vs Temperature**



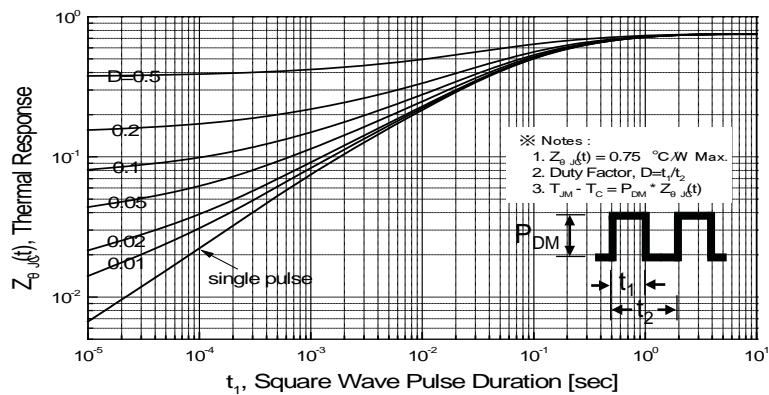
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs Case Temperature**



**Figure 11. Transient Thermal Response Curve**

Fig 12. Gate Charge Test Circuit & Waveform

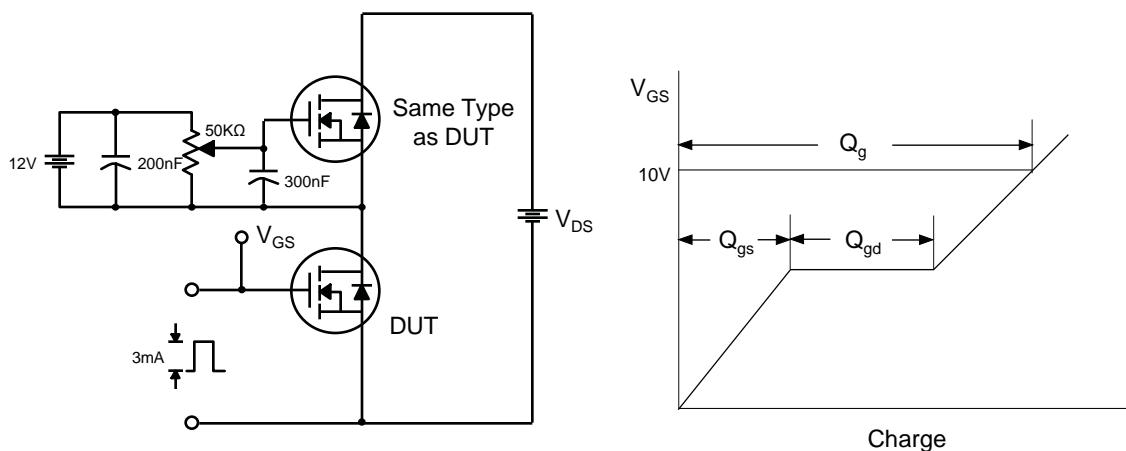


Fig 13. Resistive Switching Test Circuit & Waveforms

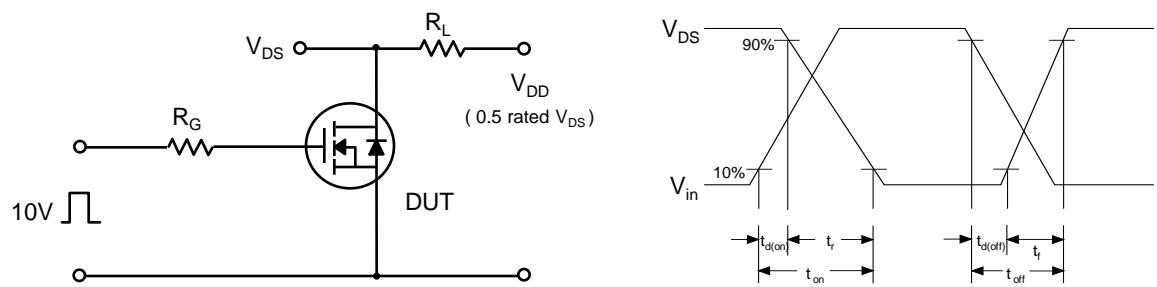
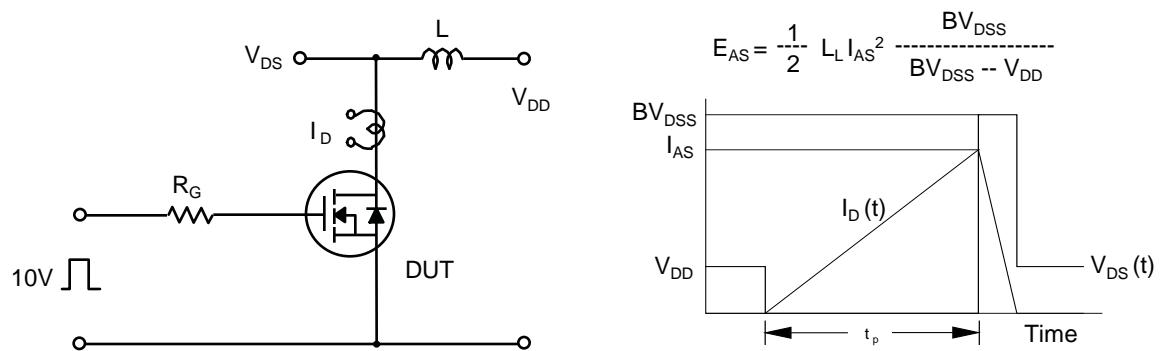
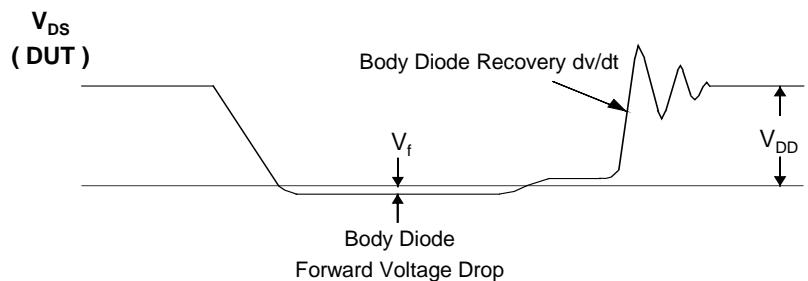
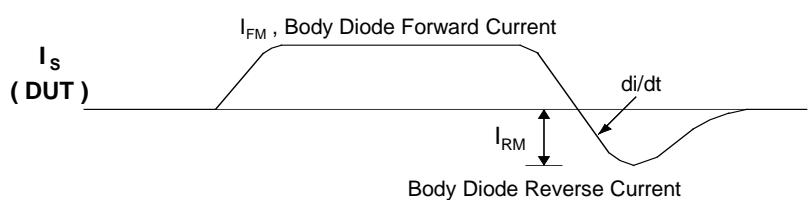
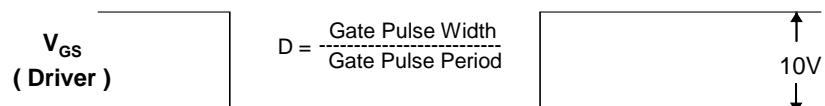
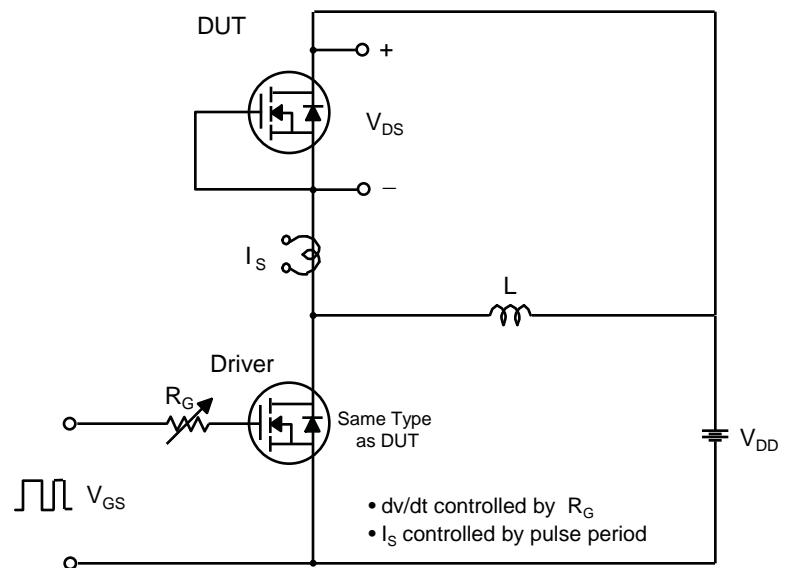


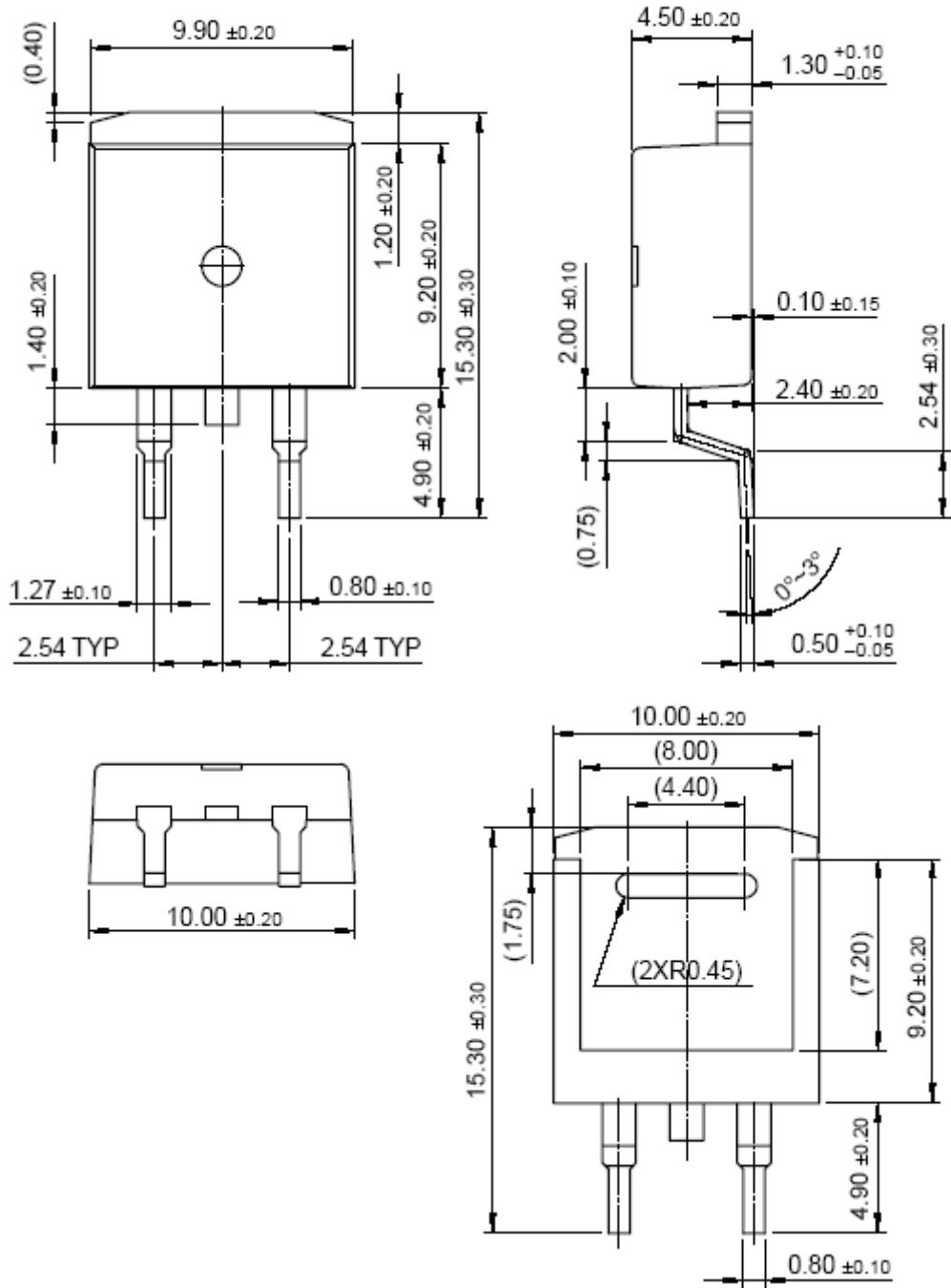
Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms



$$E_{AS} = \frac{1}{2} L_L I_{AS}^2 \frac{BV_{DSS}}{BV_{DSS} - V_{DD}}$$

Fig 15. Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms



**Package Dimension****D<sup>2</sup>PAK**

**Package Dimension****I<sup>2</sup>PAK**